

Notice of References Cited	Application/Control No. 10/632,294	Applicant(s)/Patent Under Reexamination MCCALL ET AL.	
	Examiner John F. Belena, Ph.D.	Art Unit 3746	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,915,930	06-1999	McNaull, Michael H.	417/417
	B	US-5,411,381	05-1995	Perrodin, Philip E.	417/472
	C	US-5,207,339	05-1993	Shyu, Wen-Ben	215/228
	D	US-5,022,312	06-1991	Rozek et al.	92/240
	E	US-4,483,665	11-1984	Hauser, Hugo	417/401
	F	US-4,015,913	04-1977	Nakamura, Hirokazu	417/471
	G	US-2,613,610	10-1952	BARTLETT SAALFRANK ROYAL	417/313
	H	US-2,822,121	02-1958	SADLER HARRY J; et. al.	137/209
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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